


<b>Search Notes</b>  	<b>Application/Control No.</b>  10562122	<b>Applicant(s)/Patent Under Reexamination</b>  ONO ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
restriction requirement	1-26-2008	sl
stn: registry & caplus	4-18-2008	sl
palm all inventors	4-21-2008	sl
STN: registry & caplus updated	10-17-2008	sl
PALM all inventors updated	10-17-2008	sl
STN registry & caplus updated	7-18-2009	sl
PALM all inventors updated	7-18-2009	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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